The only built-in test evaluator
BITGRADE™ from Gateway Design Automation, helps assure that complex digital systems can be tested in the field as thoroughly as in the factory by quickly and accurately determining the effectiveness of self-test schemes.

BITGRADE can deterministically fault grade hundreds of thousands of test patterns for large digital systems. Its powerful, high-level language can model nearly any self-test configuration and can precisely describe both stimulus generators and response accumulators.

BITGRADE provides for selective stimulation, monitoring, and accumulation of system-under-test inputs, internal latches, and outputs.

BITGRADE runs on IBM and DEC processors, Sun and Apollo workstations, and other popular computer platforms. When it comes to evaluating built-in self-test schemes, only BITGRADE combines accuracy, flexibility, and exceptional speed.

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